Form PTO 1449	U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO.	
(Modified)		PATENT AND TRA	DEMARK OFFICE	241531US3		10/643,993	
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LIST OF REFERENCES CITED BY APPLICANT Takeshi YAMAKAWA, et al.							
				FILING DATE		GROUP	
				August 20, 2003		2625	
U.S. PATENT DOCUMENTS							
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO	
98	AO	08-094956	12/4/96	JAPAN (w/English Abstract)			Х
	AP	2001-330792	11/30/01	JAPAN (w/English Abstract)			Х
	AQ	2001-208992	8/3/01	JAPAN (w/English Abstract)			Х
	AR	06-130263	5/13/94	JAPAN (w/English Abstract)			Х
	AS	2-64959	5/16/90	JAPAN			X
\/	AT	11-160642	6/18/99	JAPAN (w/English Abstract)			Х
₩ /H.C./	AU	2000-330056	11/30/00	JAPAN (w/English Abstract)			X
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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Examiner /Huo Long Chen/					Date Considered 08/19/2008		
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